

Substitute Form PTO-1449 (Modified)	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 13906-126001	Application No. 10/816,910
<b>Information Disclosure Statement by Applicant</b> (Use several sheets if necessary) (37 CFR §1.98(b))		Applicant Marcus Dill, et al.	
		Filing Date April 5, 2004	Group Art Unit 2171

**U.S. Patent Documents**

Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
EE	AA	2002/0144174	10/03/2002	Nwabueze			03/15/2001
EE	AB	2004/0210579	10/21/2004	Dettinger			04/17/2003
	AC						
	AD						
	AE						
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	AG						
	AH						
	AI						
	AJ						
	AK						

**Foreign Patent Documents or Published Foreign Patent Applications**

Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation	
							Yes	No
EE	AL	WO2003005232	01/16/2003	WIPO				
	AM							
	AN							
	AO							
	AP							

**Other Documents (include Author, Title, Date, and Place of Publication)**

Examiner Initial	Desig. ID	Document
	AQ	
	AR	
	AS	
	AT	
	AU	

Examiner Signature /Emeka Ebirim/	Date Considered 10/18/2006
EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	

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	Applicant		
	Filing Date <b>April 5, 2004</b>	Group Art Unit <b>Unknown</b>	

**U.S. Patent Documents**

Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
EE	AA	6,510,457	1/21/03	Ayukawa et al.			
EE	AB	6,460,037	10/1/02	Weiss et al.			
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EE	AD	6,301,471	10/9/01	Dahm et al.			
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EE	AH	6,049,599	4/11/00	McCausland et al.			
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Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
EE	AA	2002/0133490	09/19/2002	Conkwright,			12/18/2001
EE	AB	2004/0002961	01/01/2004	Dettinger,			06/27/2002
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